



# **THCV2712**

V-by-One® HS Distributor

### **General Description**

The THCV2712 is a high performance 1:2 signal distributor for V-by-One® HS with data rates up to 4Gbps and integrated 2:1 and 1:2 signal switcher support bi-directional communication.

The THCV2712 features the distribution function which duplicates a V-by-One<sup>®</sup> HS signal and the switch function which changes the path of signals. All configurations are supported by external pins.

All driver outputs and receiver inputs are internally terminated which no require external components.

#### **Features**

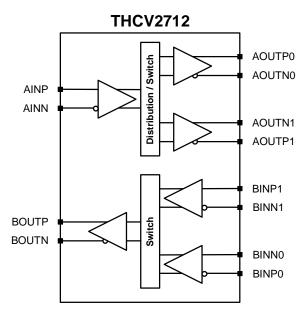
- Unidirectional Distribution
- Bi-directional Switch (1:2 and 2:1)
- Transmit VOD Control: 600 to 1300 mVp-p
- Available in single supply voltage 3.3V with integrated LDO
- ESD: HBM ±4kV
- QFN40 (5.0mm x 5.0mm)

#### **Applications**

All V-by-One® HS applications such as

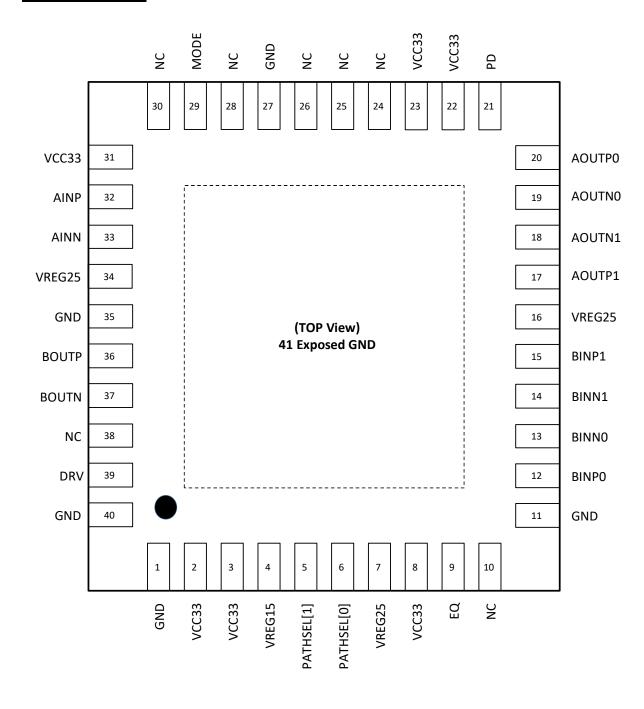
- Digital Signage
- Digital Blackboard
- Multi-Function Printer
- Production Printer
- Medical Imaging
- Machine Vision
- Image Sensor
- Camera

#### **Block Diagram**





# **Pin Configuration**





**Pin Description** 

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Pin Name	Pin No	Туре	Description
AINP	32	CI	High-Speed CML Channel A (CHA) Signal Input
AINN	33	CI	High-Speed CML Channel A (CHA) Signal Input
BOUTP	36	CO	High-Speed CML Channel B (CHB) Signal Output
BOUTN	37	СО	High-Speed CML Channel B (CHB) Signal Output
AOUTP1	17	CO	High-Speed CML Port 1 of CHA Signal Output
AOUTN1	18	CO	High-Speed CML Port 1 of CHA Signal Output
AOUTP0	20	CO	High-Speed CML Port 0 of CHA Signal Output
AOUTN0	19	CO	High-Speed CML Port 0 of CHA Signal Output
BINP1	15	CI	High-Speed CML Port 1 of CHB Signal Input
BINN1	14	CI	High-Speed CML Port 1 of CHB Signal Input
BINP0	12	CI	High-Speed CML Port 0 of CHB Signal Input
BINN0	13	CI	High-Speed CML Port 0 of CHB Signal Input
PD	21	I	Power Down 0: Operation 1: Chip Power Down
MODE	29	I	Mode select 0 : Distribution 1 : Switch
PATHSEL[1:0]	5,6	1	Select Switch Input / Output
EQ	9	3LI	Rx equalizer setting.
DRV	39	3LI	Tx output swing control
VREG15	4	PWR	Decoupling Capacitor Pin for On-chip Regulator.
VREG25	7,16,34	PWR	Decoupling Capacitor Pin, 2.5V output.
VCC33	2,3,8,22, 23,31	PWR	Power supply pin for on-chip regulator.
GND	1,11,27, 35,40,41	GND	Ground. Must be tied to the PCB ground plane through an array of vias. Pin#41 is exposed pad ground.
NC	10,24,25, 26,28,30, 38	NC	Non-connection pin. Must be open.

CI: CML Input buffer, CO: CML Output buffer

I: LVCMOS Input buffer, 3LI: 3-Level LVCMOS Input buffer, PWR: Power supply, GND: Ground, NC: Non-connection pin

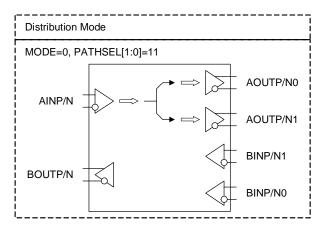


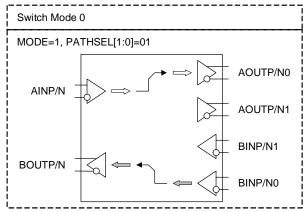
# **Operation Mode Settings**

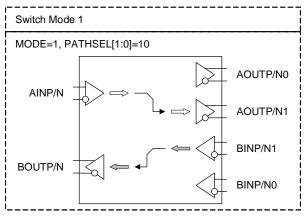
Table1 shows the operation mode setting.

**Table 1. Operation Mode Setting** 

	Pin Settings		Operation Mode
PD	MODE	PATHSEL[1:0]	Operation Mode
	0	11	Distribution Mode
0	4	01	Switch Mode Port 0 Enable
	'	10	Switch Mode Port 1 Enable
1	Ignore	Ignore	Chip Power Down.







LOCKN/HTPDN signals are not be distributed and switched. The signals should be bypassed THCV2712.



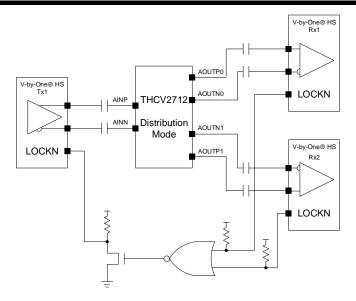


Figure 1. LOCKN circuits in Distribution Mode

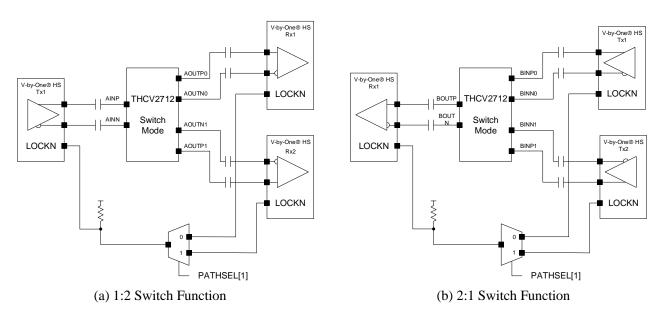


Figure 2. LOCKN circuits in Switch Mode



# **Absolute Maximum Ratings**

**Table 2. Absolute Maximum Ratings** 

Par	ameter	Min	Тур	Max	Unit
Supply Vo	Supply Voltage(VCC33)			4.0	V
	Input Voltage	-0.3	-	VCC33+0.3	V
	CMOS Input Voltage	-0.3	-	VCC33+2.5	V
	3-Level LVCMOS Input Voltage			VCC33+0.3	V
	CML Receiver Input Voltage			3.0	V
CML Transmitt	er Output Voltage	-0.3	-	3.0	V
ESD Rating	HBM	-	-	±4	kV
E3D Rating	CDM	-	-	±500	V
Storage <sup>-</sup>	Storage Temperature			125	Ô
Junction <sup>1</sup>	-	-	125	Ô	
Reflow Peak 1	emperature/Time	-	-	260/10	°C/sec

# **Recommended Operating Conditions**

**Table 3. Recommended Operating Condition** 

Parameter	Min	Тур	Max	Unit
Supply Voltage(VCC33)	3.0	3.3	3.6	V
Supply Ramp Requirement	0.1	-	50	ms
Operating Temperature	-40	-	85	°C



# **Electrical Specification**

LVCMOS DC Specification

### **Table 4. LVCMOS DC Specification**

Over recommended operating supply and temperature range unless otherwise specified

Symbol	Parameter	Condition	Min	Тур	Max	Unit
VIH	High Level Input Voltage	-	2.0	-	VCC33	V
VIL	Low Level Input Voltage	-	0	-	0.7	V
VOH	High Level Output Voltage	I <sub>oh</sub> =-2mA	2.4	-	VCC33	V
VOL	Low Level Output Voltage	I <sub>ol</sub> =8mA	0	-	0.4	V
IOZH	Output Leak Current High in Hi-Z State	-	-15	-	15	uA
IOZL	Output Leak Current Low in Hi-Z State	-	-15	-	15	uA

#### 3-Level LVCMOS DC Specification

#### Table 5. 3-Level LVCMOS DC Specification

Over recommended operating supply and temperature range unless otherwise specified

Symbol	Parameter	Condition	Min	Тур	Max	Unit
V <sub>THL</sub>	Low-Level Threshold Voltage	*	0.42	0.83	1.25	V
Vтнн	High-Level Threshold Voltage	*	1.25	1.67	2.08	V
I <sub>IH_3L</sub>	High Level Input Leak Current	VIN=VCC33	-100	-	100	uA
I <sub>IL_3L</sub>	Low Level Input Leak Current	VIN=GND	-100	-	100	uA

<sup>\*</sup>Must be tied for setting each level

Low: Tie 1k  $\Omega$   $\pm 5\%$  to GND

Float: Leave pin open

High: Tie 1k  $\Omega$  ±5% to VCC33

#### Supply Current

#### **Table 6. Supply Current**

Over recommended operating supply and temperature range unless otherwise specified

Symbol	Parameter	Condition	Min	Тур	Max	Unit
		PD=0,MODE=1 EQ=High DRV=High	-	-	170	mA
ICCW	Active Mode Supply Current	PD=0,MODE=1 EQ=Low DRV=Low	-	90	-	mA
		PD=0,MODE=0	-	-	250	mA
ICCS	Power Down Supply Current	PD=1	-	1.0	2.0	mA



### Receiver DC/AC Specification

### Table 7. Receiver DC/AC Specification

Over recommended operating supply and temperature range unless otherwise specified

Symbol	Parameter	Condition	Min	Тур	Max	Unit
V <sub>RX-TH</sub>	CML Differential Input High				50	mV
V RX-1H	Threshold		_	-	30	IIIV
$V_{RX-TL}$	CML Differential Input Low		-50	_	_	mV
V RX-IL	Threshold		-30	_	_	IIIV
$V_{RX-RIN}$	CML Differential Input Resistance		80	100	120	Ω
V <sub>RX-EQ-LOW</sub>	Input Equalization@2GHz	EQ=Low	-	3.2	-	dB
V <sub>RX-EQ-FLOAT</sub>	Input Equalization@2GHz	EQ=Float	-	4.6	-	dB
V <sub>RX-EQ-HIGH</sub>	Input Equalization@2GHz	EQ=High	-	7.6	-	dB

# Transmitter DC / AC specifications

### Table 8. Transmitter DC / AC specification

Over recommended operating supply and temperature range unless otherwise specified

Currente a l	Devementer	Condition	Min	Time	Max	l lm!4
Symbol	Parameter	Condition	Min	Тур	Max	Unit
VTX-DIFF-PP-LOW	Differential p-p Tx Voltage Swing	DRV=Low	0.4	0.6	0.8	
V <sub>TX-DIFF-PP-FLOQT</sub>	Differential p-p Tx Voltage Swing	DRV=Float	0.8	1.0	1.2	V
VTX-DIFF-PP-HIGH	Differential p-p Tx Voltage Swing	DRV=High	1.0	1.3	1.6	
R <sub>TX-DIFF-DC</sub>	DC Differential Impedance	-	80	100	120	Ω
Vтх-dc-см	Transmitter DC Common-mode Voltage	-	-	1.9	-	٧
ITX-SHORT	Transmitter Short-circuit Current Limit	-	-	20	60	mA
TACTIVE	PD Low to CML Output Delay				200	ns
TPOWERDOWN	PD High to CML Output High Fix Delay				10	ns
T <sub>SKEW</sub>	CML Output Inter-pair skew				25	ps
T <sub>PROPAGATION</sub>	Differential Propagation Delay	-	-	150	-	ps
<b>ΔT</b> PROPAGATION	Delta Propagation Delay		-	-	90	ps
T <sub>SWITCH</sub>	Switching Time	-	-	-	10	ns

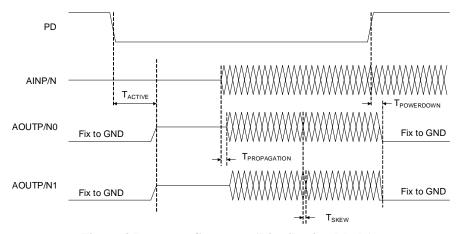


Figure 3 Power on Sequence (Distribution Mode)



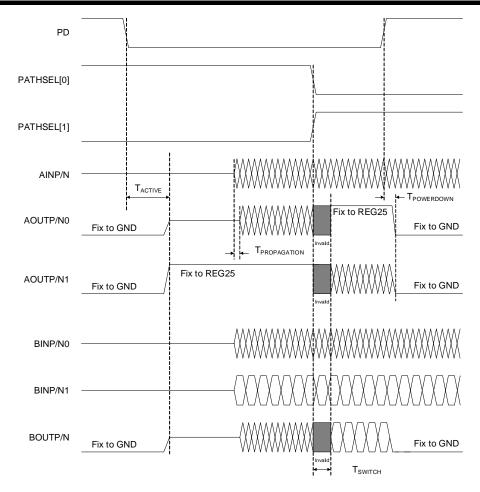


Figure 4. Power on Sequence (Switch Mode)

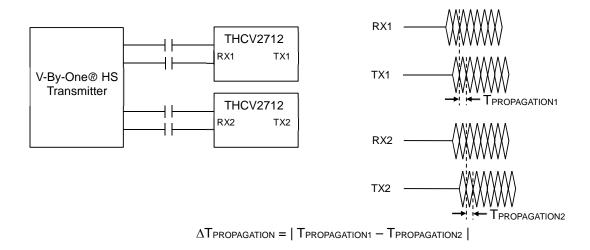
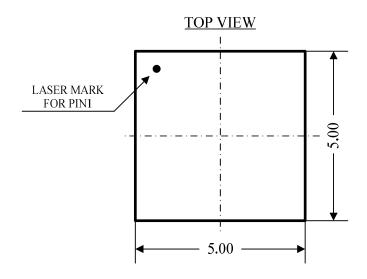


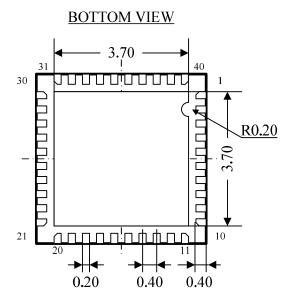
Figure 5. CML Propagation Delay Timing

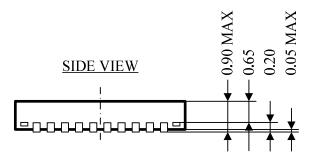
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# **Package**







Unit: mm

Figure 6. 40-pin QFN package physical dimension



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